

**Search Notes**

Application/Control No.

10/805,346

Examiner

Evan Dzierzynski

Applicant(s)/Patent under  
Reexamination

WANG ET AL.

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	240	4/18/2006	ED
	555	4/18/2006	ED
	559	4/18/2006	ED
	252	4/18/2006	ED
	545	4/18/2006	ED

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST word search, see attachment	4/18/2006	ED